Issue Classification

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Application No.	Applicant(s)	_
10/807,790	ISHIGAKI, TSUNEO	
Examiner	Art Unit	_
KEVIN L LEE	3753 .	

		IS	SUECI	ASSIF	ICATION	1							
	RIGINAL		CROSS/REFERENCE(S)										
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
137	613	251	326	301									
INTERNATIO	NAL CLASSIFICATION												
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(Assk	slant Examiner) (Date				in Logi: Stanling:	Total Claims Allowed: 12							
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Claims re	Claims renumbered in the same order as presented by applicant					☐ CPA		☐ T.D.			☐ R.1.47					
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(1)		31			61	1		91			121		151			181
2 2		32			62	1		92			122		152			182
3 3		33			63			93			123		153			183
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5 6	<u> </u>	36			66	1		96			126		156			186
6 7		37			67	1		97			127		157	•		187
7 8		38	:		68	1		98			128		158			188
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9 10		40			70	1		100			130	•	160			190
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14		44			74	1		104			134		164			194
15	-	45		 	75	1		105			135		165			195
16	<u> </u>	46		<u> </u>	76	1		106			136	-	166			196
17	-	47			77	1		107			137		167			197
18		48			78	1		108			138		168			198
19		49			79	i		109			139		169			199
20		50			80	1		110			140		170			200
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24	<u> </u>	54			84	1		114			144		174			204
25	<u> </u>	55			85	i		115			145		175		<u> </u>	205
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28		58		<u> </u>	88	Í		118			148		178			208
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